Docket No.

210314US2/ims

IN THE UNITE NT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Toshiaki SHINOHARA

SERIAL NO: 09/895,319

GAU:

2814

FILED:

July 2, 2001

EXAMINER: D. P. NGUYEN

FOR:

SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

Applicant(s) wish to disclose the following information.

COPY

REFERENCES

- The applicant(s) wish to make of record the references cited in the attached German Office Action listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. In accordance with discussions on August 4, 2004 with Mr. Nicholas P. Godici, Commissioner for Patents, it is no longer required to submit copies of cited pending applications. A modification of the Rules will be published soon in the Official Gazette. Cited issued patents, if any, are listed on the attached PTO form 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of
- □ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Marvin J. Spivak Registration No. 24,913

Customer Number

22850

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Intercised PATENT AND TRACEAURIS COPTICE 109/695,319 APPLICANT Toshiski SHINOHARA FILING DATE July 2, 2001 2814	Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO. 210314US2		SERIAL NO. 09/895,319		
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AQ 196 25 240 04/30/1997 GERMANY (with corr. US 5,767,573) X AR 11-243166 07/09/1999 JAPAN (with English Extract) X AS 0 777 272 06/04/1997 EUROPE		AO	44 00 341	07/14/1994	GERMANY (with corr. US 5,440,169)				
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OSMM&N File No. <u>210314US2</u>

Dept.: <u>IP-I</u>

By: MJS/ims

Serial No. 09/895,319

In the matter of the Application of: Toshiaki SHINOHARA

For: SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING

SAME

Due Date: 10/06/2004

The following has been received in the U.S. Patent Office on the date stamped hereon:

■ Dep. Acct. Order Form

■ Information Disclosure Statement

■ PTO-1449

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■ Cited References (10)

■ GERMAN Office Action

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